

# TMC6130 DATASHEET

*Cost-effective high-current BLDC motor driver with state-of-the-art feature set.*

*Fastest settling time and built-in EEPROM for extensive configuration.*



## APPLICATIONS

Battery operated equipment  
Handcraft gear  
Professional healthcare  
Fail-safe applications  
Low-torque control applications  
BLDC sine wave applications  
Positioning Actuators  
Factory Automation  
Pumps and Valves  
CNC Machines

## FEATURES AND BENEFITS

**Level Shifting:**  $\mu\text{C}$  PWM outputs / 6 or 3 ext. N-FET half-bridges

**100% PWM Operation**

**Low Offset, Low Drift, Fast Current Sense Amplifier** with configurable input range

**Operating Range**  $V_M = [4.5, 28]\text{V}$ , 32V abs. max

**Fault Interrupt & Feedback** to microcontroller

**Fastest settling time** and minimum noise

**Diagnostics:** overcurrent, overtemperature, undervoltage

**Configurable communication interface** for diagnostics feedback

**Drain-Source Voltage / Gate-Source Voltage** external FET monitoring for short circuit protection

**Sleep Mode** with low quiescent current ( $<30\mu\text{A}$ )

**Compatible** with 3V and 5V microcontrollers

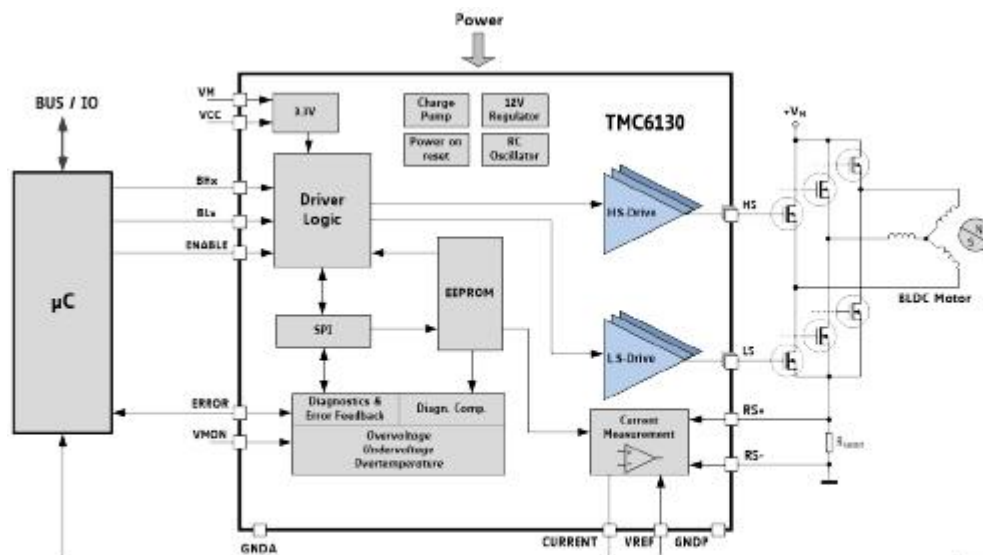
**Charge-Pump** provides NFET reverse polarity drive

**Small Size:** QFN 5x5mm package, 32 pins

## DESCRIPTION

The TMC6130 is a high-current motor driver for compact and energy efficient BLDC solutions. It is designed to drive N-type FET 3-phase motor control applications and contains all power and analog circuitry required for a high performance system. The built-in EEPROM allows extensive configurability without the need for external resistors and SPI interface programming. This reduces the pin count to only 32. All output voltages are monitored and controlled. The device comprises a current shunt amplifier with a high gain bandwidth (GBW), offering a fast settling time with low noise. A combination of bootstrap and charge pump enables driving 6 (or 3) NFETs, with gate charges up to 400nC/NFET with a minimum of device self-heating. Further, the IC reset level below 4.5V allows also for low-voltage operation.

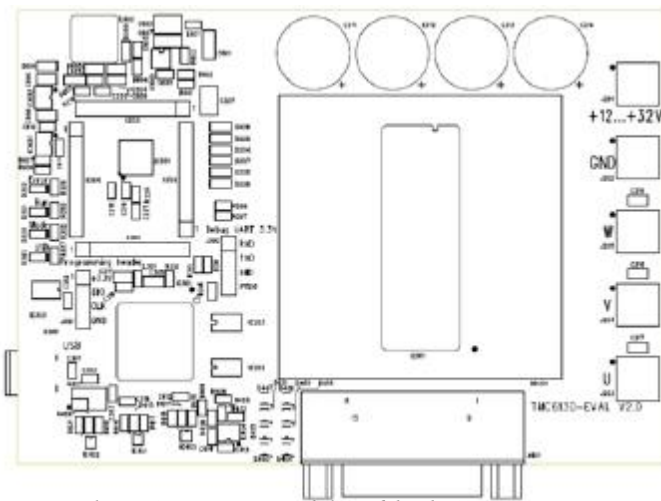
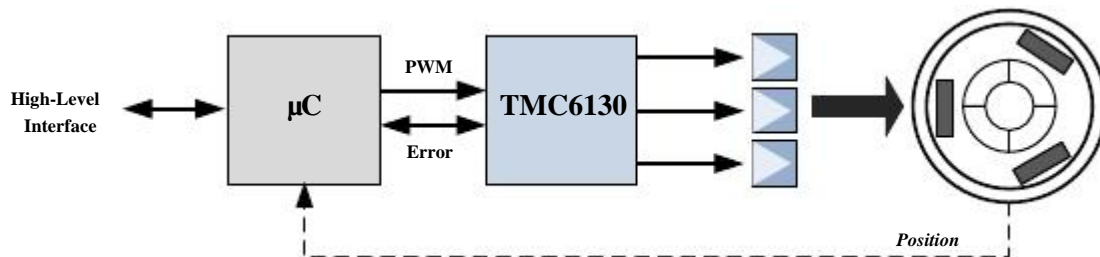
## BLOCK DIAGRAM



## APPLICATION EXAMPLES: HIGH POWER – FASTEST SETTLING TIME

The TMC6130 3-phase motor pre-driver scores with a very fast settling time, high reliability, and broad diagnostic and safety features. It can be used within a large operating range from battery systems on up to 24V DC. This versatility covers a wide spectrum of applications and motor sizes, all while keeping costs down.

Several safe operating features are integrated, including diagnostics related to all output voltages, power on reset, and short circuit protection. Diagnostics feedback is communicated to the microcontroller via a bidirectional error interface. Finally, this BLDC driver chip features a low side shunt amplifier with large gain bandwidth (GBW), ideal for torque control applications requiring very fast settling time and minimum noise. Extensive support at the chip, board, and software levels enables rapid design cycles and fast time-to-market with competitive products.



Layout with MOSFET power module (B6-bridge)

### TMC6130 EVALUATION BOARD

This evaluation board is a development platform for applications based on the TMC6130 three phase BLDC motor driver chip. Supply voltages are 4.5... 28V DC (max. 32V). The board features an embedded microcontroller with USB and RS232 (TTL level) interfaces for communication. The board offers test points for all pins of the TMC6130. For positioning, three digital hall sensors can be connected as well as an ABN encoder. Using the IOs, potentiometers and switches can be attached. JTMICs TMCBLDC software tool (running under Windows) enables access to all functions of the TMC6130 from a PC.

### ORDER CODES

| Order code   | Description                   | Size [mm] <sup>2</sup> |
|--------------|-------------------------------|------------------------|
| TMC6130-LA   | BLDC 3-phase driver, QFN32    | 5x5                    |
| TMC6130-EVAL | Evaluation board for TMC6130. | 80 x 115               |

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# 1 Principles of Operation

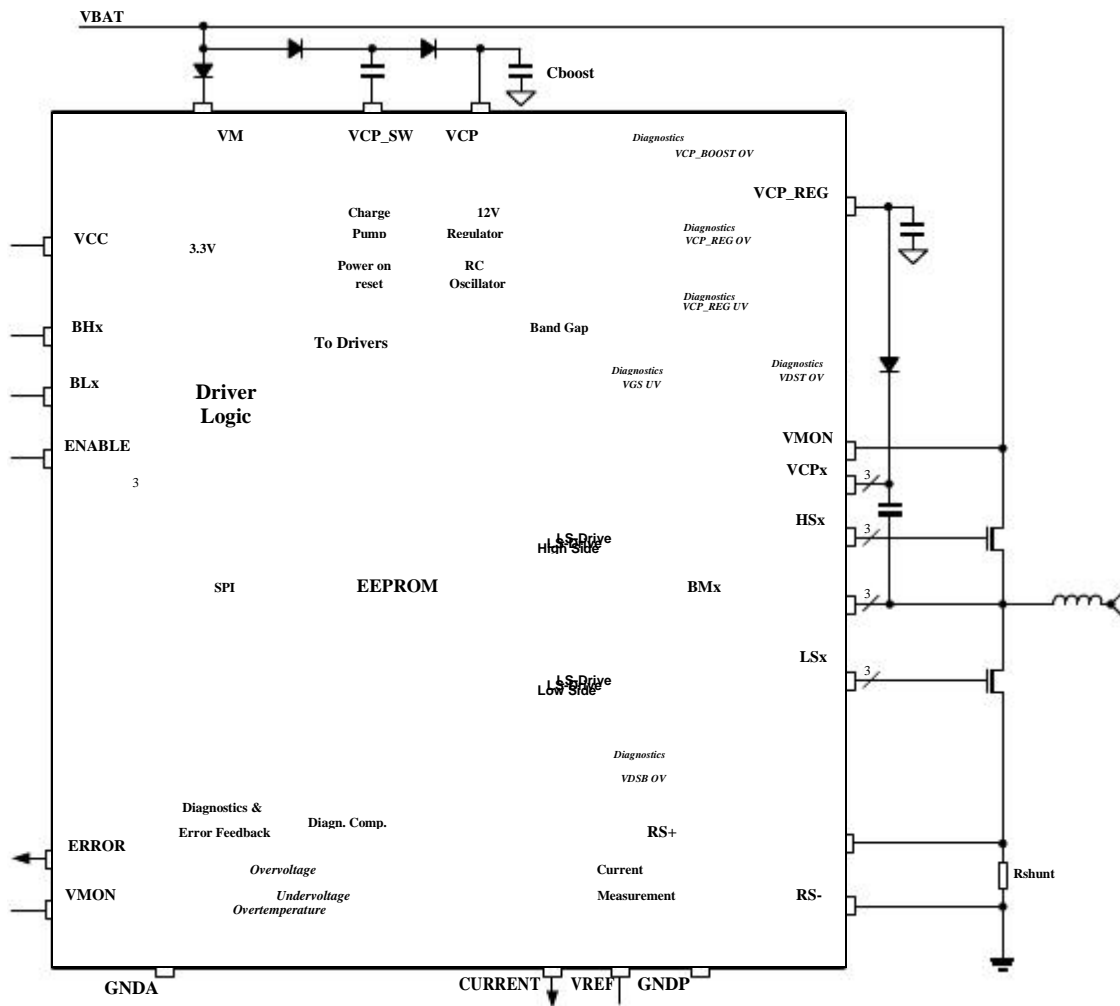


Figure 1.1 Block diagram and principle operation circuit

## 1.1 Key Concepts

The TMC6130 BLDC motor pre-driver implements advanced features which contribute toward energy efficiency, high precision, high reliability, smooth motion, and cool operation in industrial BLDC motor applications.

### Configuration

All configurations are done. The TMC6130 is equipped with a programmed EEPROM in order to simplify the design-in. In almost all cases the default values will fit. Nevertheless, special configurations are possible, if necessary.

### Interfacing

The TMC6130 communicates with the microcontroller using the ERROR input/output for diagnostic feedback. During stand still, the SPI interface on the pre-driver can be used for configuration purposes. Further, it is possible to communicate via bit banging.

**Fast Settling Time** The TMC6130 offers an extremely short settling time. The shunt amplifier has a high gain bandwidth (GBW) to reach a fast settling time with minimum noise.

### Voltage

The TMC6130 can be used within the range of 4.5V to 28V DC.

### Boost Current

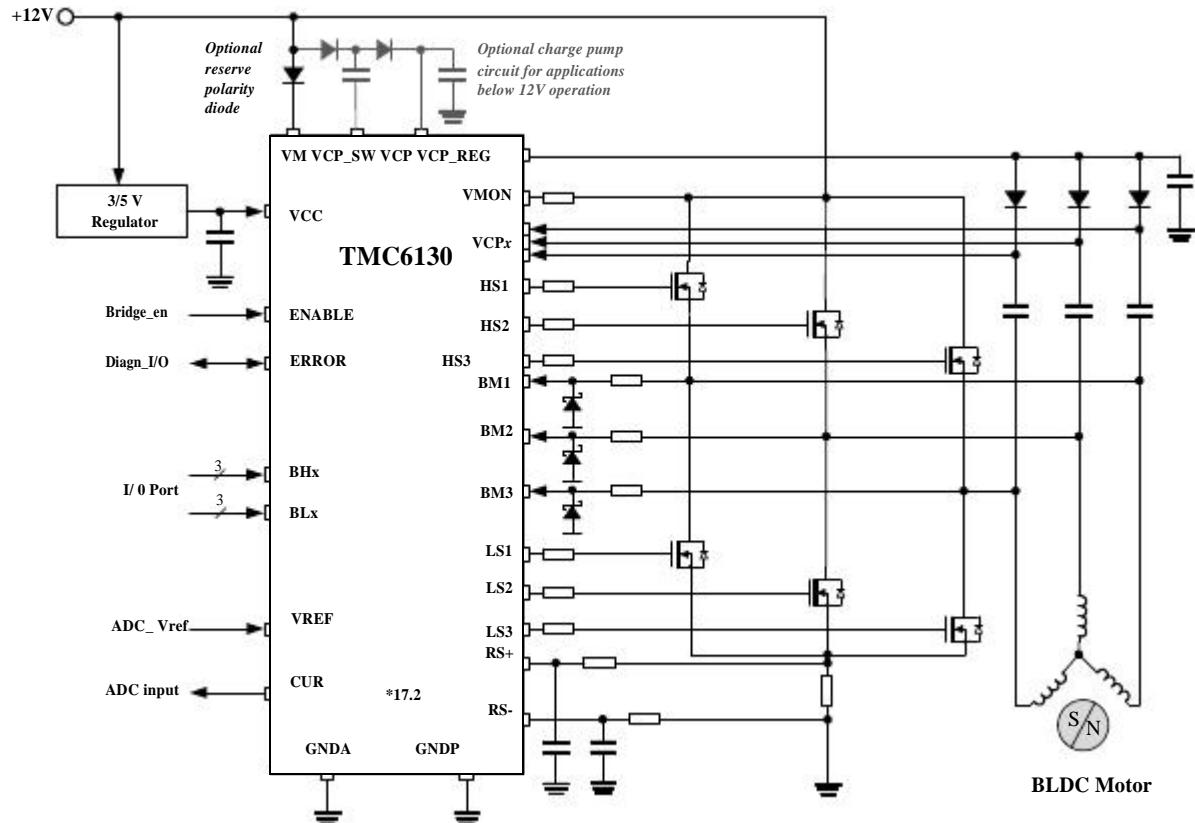
For quick motor reaction on a target setting, a higher boost current can be used. This way, the time interval for acceleration and deceleration can be shortened.

### Sleep Mode

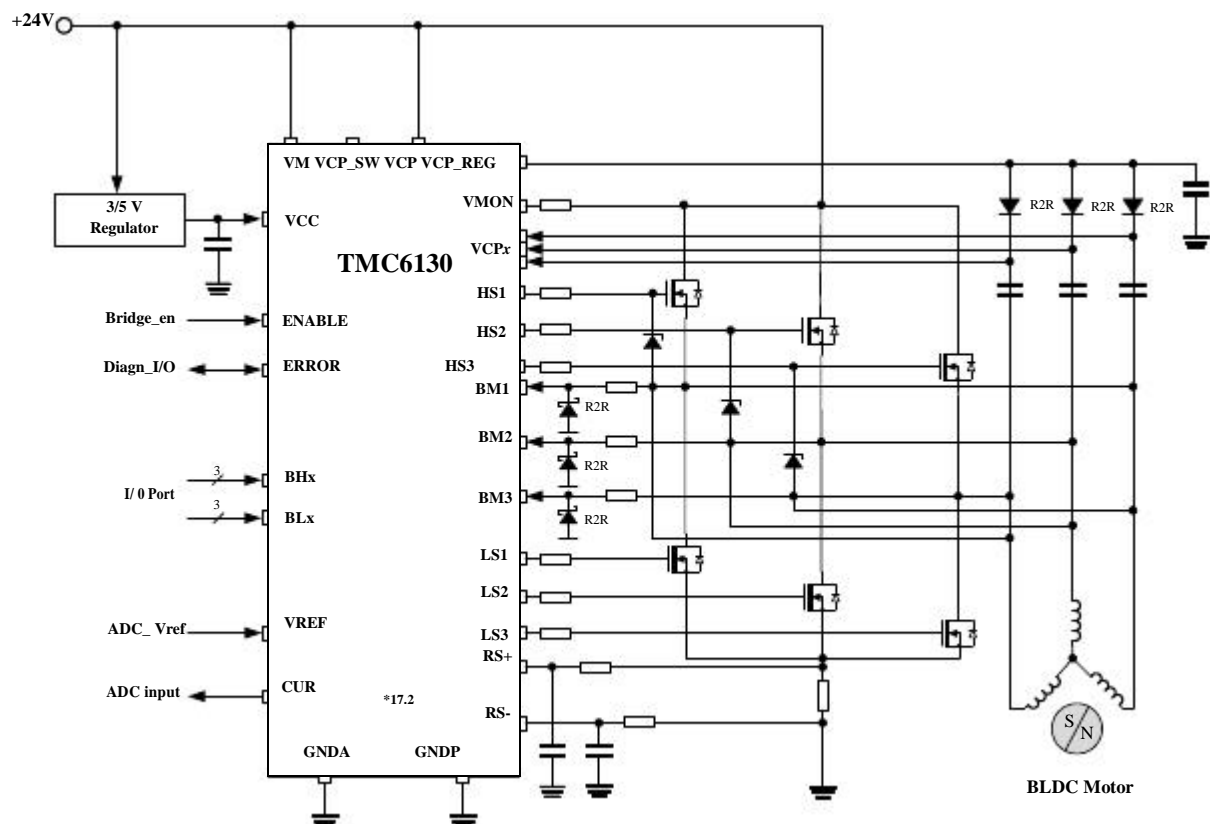
In sleep mode, the current consumption can be reduced to or below 30  $\mu$ A.

*JTMIC motor drivers also offer safeguards to detect/protect from shorted outputs, overtemperature, overvoltage, and undervoltage conditions.*

## 1.2 Application Circuits



### Figure 1.2 Application example for +12V DC



### Figure 1.3 Application example for +24V DC

## 1.2.1 Ground Connections

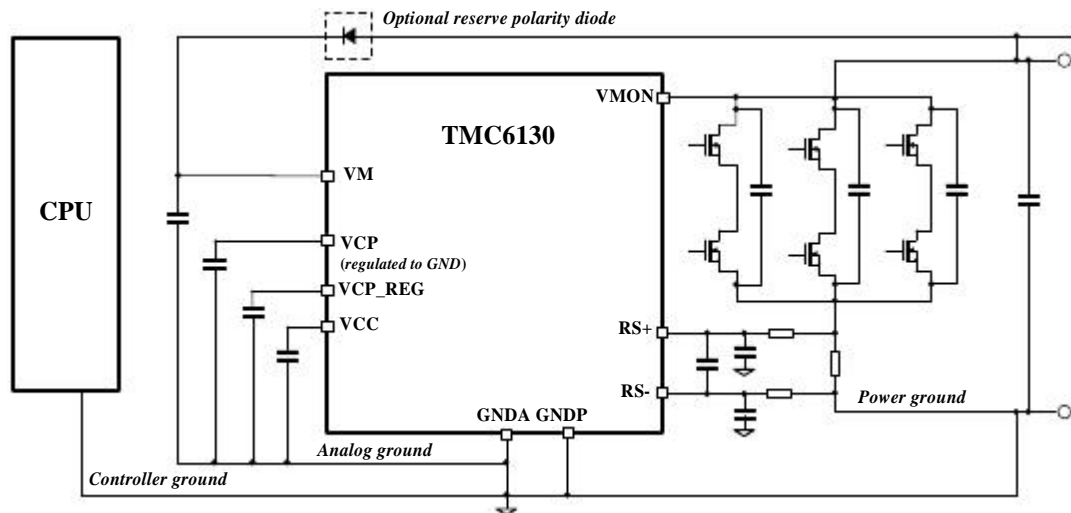
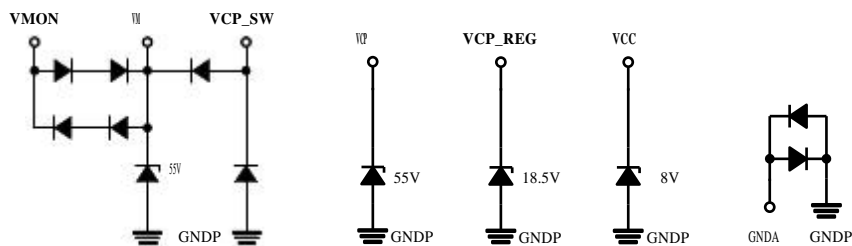


Figure 1.4 Ground connections

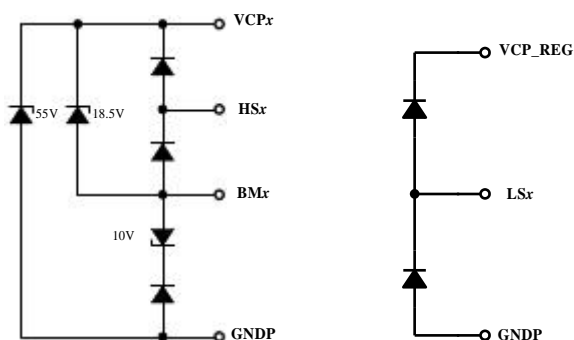
### 1.2.2 Pin Internal Connections

## SUPPLY CONNECTIONS



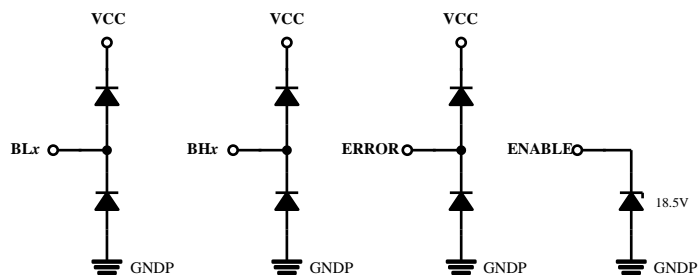
### Figure 1.5 Supply connectinons

## GATE DRIVER CONNECTIONS



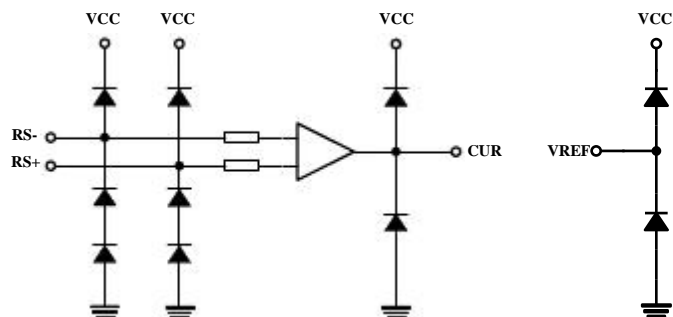
**Figure 1.6 Gate driver connections**

## DIGITAL IO CONNECTIONS



### Figure 1.7 Digital IO connections

## AMPLIFIER CONNECTIONS



### Figure 1.8 Amplifier connections

## 2 Pin Assignments

### 2.1 Package Outline

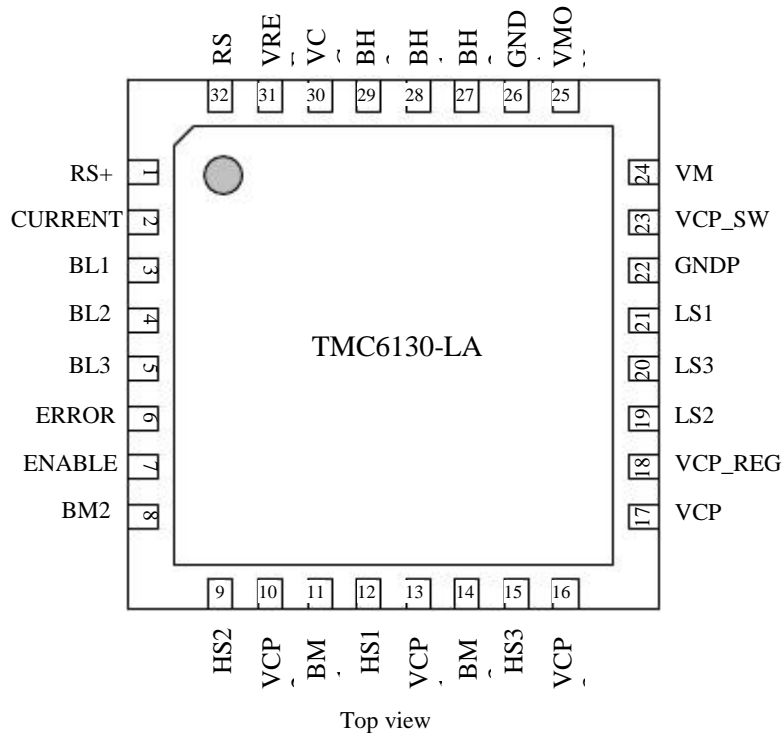


Figure 2.1 TMC6130 pin assignments

### 2.2 Signal Descriptions

| Name    | Number | Type    | Function  |
|---------|--------|---------|---|
| RS+     | 1      | Analog  | Current sensor input (positive)                           |
| CURRENT | 2      | Analog  | Current sensor output; diagnostic output in case of fault |
| BL1     | 3      | Digital | PWM input for low-side bridge n-FET1                      |
| BL2     | 4      | Digital | PWM input for low-side bridge n-FET2                      |
| BL3     | 5      | Digital | PWM input for low-side bridge n-FET3                      |
| ERROR   | 6      | IO      | Diagnostic feedback IO                                    |
| ENABLE  | 7      | IO      | Enable input  |
| BM2     | 8      | Phase   | Motor phase 2   |
| HS2     | 9      | Output  | PWM output to high-side n-FET2 gate                       |
| VCP2    | 10     | Supply  | Charge pump supply for high-side n-FET2                   |
| BM1     | 11     | Phase   | Motor phase 1   |
| HS1     | 12     | Output  | PWM output to high side n-FET1 gate                       |
| VCP1    | 13     | Supply  | Charge pump supply for high-side n-FET1                   |
| BM3     | 14     | Phase   | Motor phase 3   |
| HS3     | 15     | Output  | PWM output to high side n-FET3 gate                       |
| VCP3    | 16     | Supply  | Charge pump supply for high-side n-FET3                   |
| VCP     | 17     | Analog  | Charge pump generated supply, unregulated                 |
| VCP_REG | 18     | Analog  | Regulated output from charge pump to drive n-FET gates    |
| LS2     | 19     | Output  | PWM output to low-side n-FET2 gate                        |
| LS3     | 20     | Output  | PWM output to low-side n-FET3 gate                        |
| LS1     | 21     | Output  | PWM output to low-side n-FET1 gate                        |
| GNDP    | 22     | Ground  | Driver ground   |
| VCP_SW  | 23     | Analog  | Output of charge pump to boost low battery                |

| Name | Number | Type    | Function  |
|------|--------|---------|---|
| VM   | 24     | Supply  | Power supply input  |
| VMON | 25     | Input   | Supply for 3 high-side n-FETs to monitor drain source voltage $V_{DS}$  |
| GNDA | 26     | Ground  | Analog ground   |
| BH2  | 27     | Digital | PWM input for high-side n-FET2  |
| BH1  | 28     | Digital | PWM input for high-side n-FET1  |
| BH3  | 29     | Digital | PWM input for high-side n-FET3  |
| VCC  | 30     | Supply  | The input voltage on VCC is used to drive the digital IO's, and is used to supply the shunt amplifier.<br>Sleep mode control: VCC = 0V puts the pre-driver in sleep mode. |
| VREF | 31     | Analog  | Reference voltage input for current sense   |
| RS-  | 32     | Analog  | Current sensor input (negative)   |

**Table 2.1 Pin definitions and descriptions**

## 3 Currents and Current Control

### 3.1 Supply Systems

The current for operation of the system is supplied via  $V_M$  and  $V_{CC}$ .  $V_{CC}$  supplies the IOs, and the amplifier. In case  $V_{CC}$  is supplied with a limited output impedance (for instance from a microcontroller IO), the performance of the amplifier may be affected.  $V_M$  supplies the internal operation and the charge pump.

There are two possibilities to connect the boost current capacitor to the TMC6130. For charge pump mode 0 (default setting), connect it to VCP as shown in Figure 3.1.

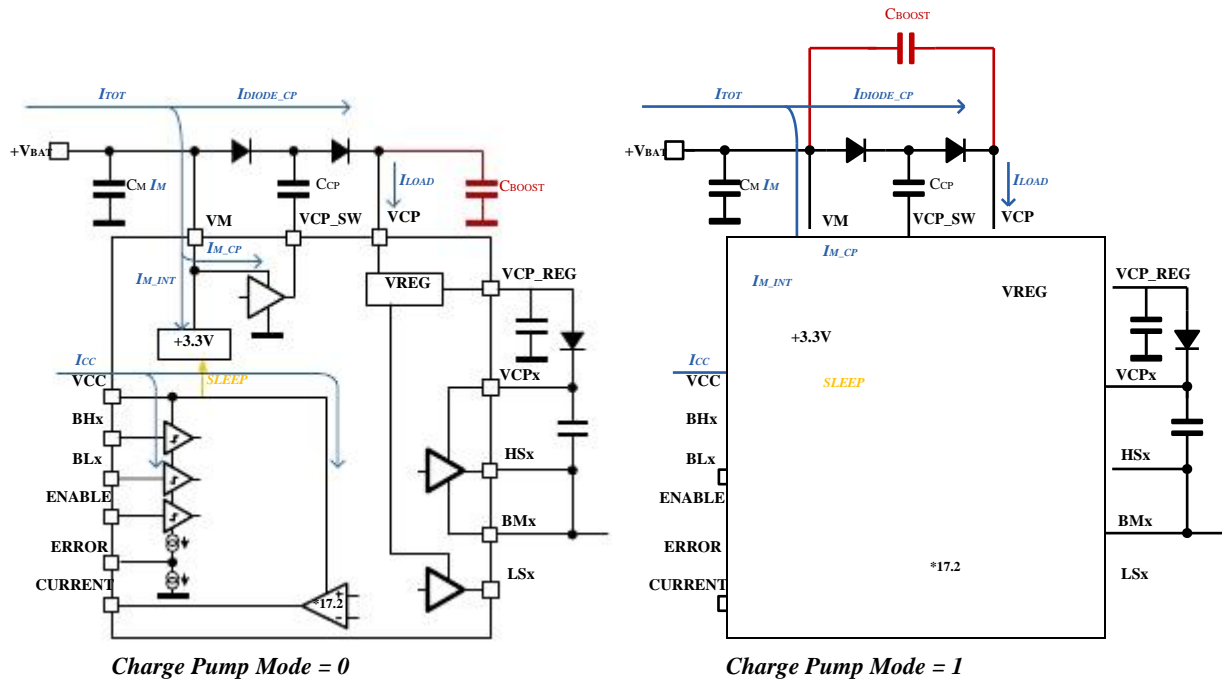


Figure 3.1 Power supply systems: CPMODE = 0 and CPMODE = 1

#### STANDARD OPERATION: CHARGE PUMP MODE = 0

The standard operation of the charge pump is to ensure sufficient gate voltage to the bootstrap capacitors in case of low voltage conditions.  $V_{BOOST}$  is regulated compared to GND level. The charge pump will not be switching when  $V_M > V_{REG} + 2 \cdot V_F$  with  $V_F$  = forward voltage of charge pump diodes.

#### CHARGE PUMP MODE = 1 *(has to be programmed and stored in EEPROM via SPI)*

Alternatively, the charge pump can regulate  $V_{BOOST}$  compared to  $V_M$ . In this case the  $C_{BOOST}$  capacitor should be connected to  $V_M$  to ensure any supply variations are coupled to the  $V_{BOOST}$  level. The disadvantage is an additional amount of dissipation inside the pre-driver to regulate  $V_{REG}$ .

The default configuration is stored in the integrated EEPROM. In case CPMODE1 is desired, it is necessary to change EEPROM configuration bits (using the SPI interface or via bit banging).

## 3.2 100% PWM with Bootstrap

A current is drawn from the VCP\_SW pin to the phase pins. This current will discharge the gate voltage on top of any external pull down gate resistance.

| CALCULATION EXAMPLE 1 |           |           |
|-----------------------|-----------|-----------|
| Parameter             | Value     | Unit      |
| bootstrap             | 330       | nF        |
| VCP_reg               | 12        | V         |
| Qbootstr              | 3960      | nC        |
| QFET                  | 200       | nC        |
| VGS_initial           | 11.4      | V         |
| Rcp_leak              | 0.75      | MΩ        |
| Leakage               | 15        | μA        |
| <i>On time</i>        | <i>60</i> | <i>ms</i> |
| Qleak                 | 914       | nC        |
| VGS_end               | 9.4       | V         |
| VGS_drop              | 2.06      | V         |

| CALCULATION EXAMPLE 2 |           |           |
|-----------------------|-----------|-----------|
| Parameter             | Value     | Unit      |
| bootstrap             | 100       | nF        |
| VCP_reg               | 12        | V         |
| Qbootstr              | 1200      | nC        |
| QFET                  | 120       | nC        |
| VGS_initial           | 10.9      | V         |
|                       |           |           |
| Leakage               | 15        | μA        |
| <i>On time</i>        | <i>10</i> | <i>ms</i> |
| Qleak                 | 152       | nC        |
| VGS_end               | 9.8       | V         |
| VGS_drop              | 1.13      | V         |

This gate leakage will limit the maximum state time during which 100% PWM can be applied.

## 3.3 Current Consumption in Sleep Mode

Sleep mode is activated when the supply input VCC is pulled below VCC\_SLEEP level. In sleep mode, the current consumption is reduced to ISLEEP.

| Pin                                   | Current consumption in Sleep Mode   | Input/Output |
|---------------------------------------|---|--------------|
| BHx<br>BLx<br>ENABLE<br>VREF<br>ERROR | Input pins, supplied from VCC   | GND          |
| CURRENT                               | Supplied from VCC   | GND          |
| VCP_REG                               | Supply regulator disabled   | GND          |
| VCP                                   | Externally connected to supply.   | ~VBAT        |
| VCP_SW                                | Charge pump disabled.   | GND          |
| VCPx                                  | Any charge that remains after VCP_REG is disabled will leak to ground.                          | GND          |
| HSx<br>BMx                            | VM > 4.5V<br>In sleep mode, gate-discharge-resistors (RSGD) between HSx and BMx are activated.  | GND          |
| LSx                                   | VM > 4.5V<br>In sleep mode, gate-discharge-resistors (RSGD) between LSx and DGND are activated. | GND          |

### ATTENTION!

In case input pins are externally pulled high while VCC is low, current will flow into VCC via internal protection diodes. *This condition is not allowed!*

When VCC is pulled low, also ERROR will go low. This should not be interpreted as a diagnostic interrupt.

**STATES IN SLEEP MODE**

| Name    | Number | Type    | State in Sleep Mode                                  |
|---------|--------|---------|--|
| RS+     | 1      | Analog  | GND  |
| CUR     | 2      | Analog  | GND (tied to VCC)                                    |
| BL1     | 3      | Digital | GND (tied to VCC)                                    |
| BL2     | 4      | Digital | GND (tied to VCC)                                    |
| BL3     | 5      | Digital | GND (tied to VCC)                                    |
| ERROR   | 6      | IO      | GND (tied to VCC)                                    |
| ENABLE  | 7      | IO      | GND (tied to VCC)                                    |
| BM2     | 8      | Phase   | Connected via diode to GATE2                         |
| HS2     | 9      | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| VCP2    | 10     | Supply  | Any present charge leaks to GND                      |
| BM1     | 11     | Phase   | Connected via Diode to GATE1                         |
| HS1     | 12     | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| VCP1    | 13     | Supply  | Any present charge leaks to GND                      |
| BM3     | 14     | Phase   | Connected via Diode to GATE3                         |
| HS3     | 15     | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| VCP3    | 16     | Supply  | Any present charge leaks to GND                      |
| VCP     | 17     | Analog  | Connected via charge pump diodes to V <sub>BAT</sub> |
| VCP_REG | 18     | Analog  | GND  |
| LS2     | 19     | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| LS3     | 20     | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| LS1     | 21     | Output  | Internal pull down (R <sub>SGD</sub> ) to GND        |
| GNDP    | 22     | Ground  | Driver ground  |
| VCP_SW  | 23     | Analog  | GND  |
| VM      | 24     | Supply  | Power supply input                                   |
| VMON    | 25     | Input   | Connected to supply                                  |
| GND A   | 26     | Ground  | Analog ground  |
| BH2     | 27     | Digital | GND (tied to VCC)                                    |
| BH1     | 28     | Digital | GND (tied to VCC)                                    |
| BH3     | 29     | Digital | GND (tied to VCC)                                    |
| VCC     | 30     | Supply  | Externally pulled low                                |
| VREF    | 31     | Analog  | GND  |
| RS-     | 32     | Analog  | GND  |

## 4 Diagnostics

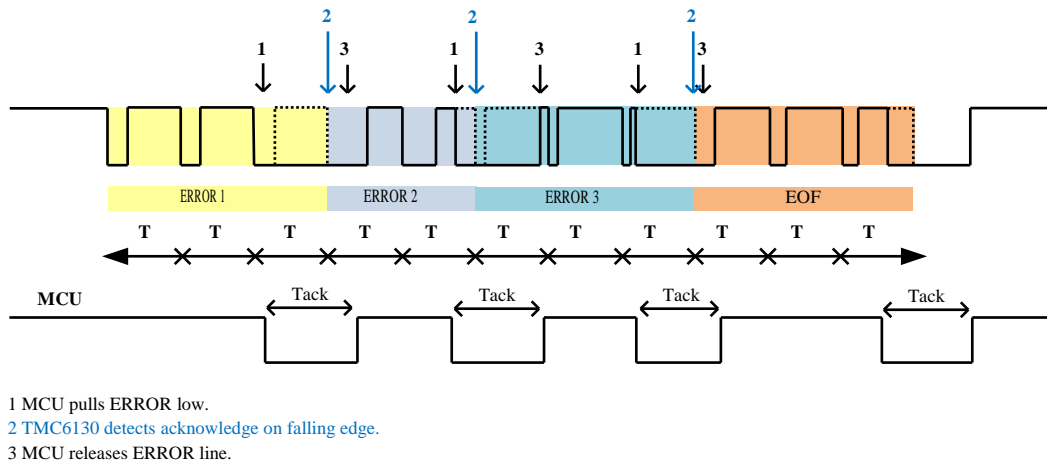
### 4.1 ERROR Interface

ERROR is a serial interface that feeds back detailed diagnostics information to the microcontroller. Two modes for supplying diagnostic feedback can be used (configured in EEPROM). The default configuration for the TMC6130 is  $\text{PWM\_SPEED} = 1$ .

**PWM\_SPEED = 0**      Slow response diagnostic mode  
PWM period  $T_{\text{ERROR}} \approx 64 \mu\text{s}$  for frequency  $F_{\text{ERROR\_S}}$

**PWM\_SPEED = 1**      Fast response diagnostic mode  
PWM period  $T_{\text{ERROR}} \approx 10 \mu\text{s}$  for frequency  $F_{\text{ERROR\_F}}$

In these modes detailed diagnostic information is provided in the form of a PWM duty cycle. Each error corresponds to one duty cycle. The duty cycle is transmitted until the microcontroller acknowledges the reception of the duty cycle. The microcontroller acknowledges by pulling the ERROR line low for a period  $T_{\text{ACK}} > T_{\text{ERROR}}$ .



**Figure 4.1 ERROR handshake protocol**

At each falling edge the TMC6130 checks the actual voltage on the ERROR line to detect an acknowledgement. When an acknowledgement is detected the duty cycle value is changed to the corresponding duty cycle value of the highest priority next error that has not yet been transmitted. This sequence of capturing duty cycle and acknowledging continues until the end of the frame (EOF) duty cycle has been received. By acknowledging the EOF duty cycle all error latches are reset and the ERROR line goes high again until a new error occurs.

#### ATTENTION

- It is possible that a lower priority error is transmitted before a higher priority error because the higher priority error occurred after the start of transmission of the lower priority error.
- When  $V_{\text{CC}}$  is pulled low to put the TMC6130 into sleep mode, ERROR will go low as well. As soon as  $V_{\text{CC}}$  goes high, ERROR will go high as well and remains high: no EOF is required in this case.
- As long as the regulated voltages on VCP and VCP\_REG have not been achieved, ERROR may immediately start to go in diagnostic mode. This implies the microcontroller has to acknowledge these errors until the undervoltage conditions have been resolved. As soon as ERROR no longer enters diagnostic mode, the pre-driver is ready for operation.



## 4.2 Hardware Protection

Hardware protection refers to the capability of the microcontroller to turn off the TMC6130 pre-driver without intervention in case of error condition. All gate voltages have to be pulled low to Z-state. An overvoltage condition on VM will always switch off the pre-driver, in order to protect it. This safety feature cannot be masked.

### 4.2.1 VDS Overvoltage

The reaction of the pre-driver on VDS (drain source voltage) overvoltage events can be configured in EEPROM with bridge feedback (BF) bits.

Per default configuration, *VDS\_COMP\_EN* and *VDS\_BF\_EN* are set to 1. Thus, in case of VDS overvoltage, ERROR reports error and the pre-driver is enabled.

For any other EEPROM configuration it is necessary to use the SPI interface or to communicate with the microcontroller via bit banging. Note, that in most cases it is not necessary to change EEPROM settings. Therefore, information about programming the EEPROM via SPI is subject of an application note and not mentioned here.

| VDS_COMP_EN | VDS_BF_EN | Reaction  |
|-------------|-----------|---|
| 0           | -         | Any possible drain source (VDS) overvoltage events are neglected: no reaction on ERROR line. Pre-driver remains active. |
| 1           | 0         | ERROR reports error and pre-driver remains active.  |
| 1           | 1         | ERROR reports error and pre-driver is disabled.   |

### 4.2.2 VCP\_REG Overvoltage

The reaction of the pre-driver on VCP\_REG overvoltage events can be configured in EEPROM with bridge feedback (BF) bits.

The default configuration is *VCP\_REG\_OV\_BF\_EN* = 1. Thus, ERROR reports error and bridge driver is set in tri-state if the error flag *VCP\_REG\_OV* is set.

For any other EEPROM configuration it is necessary to use the SPI interface or to communicate with the microcontroller via bit banging. Note, that in most cases it is not necessary to change EEPROM settings. Therefore, information about programming the EEPROM via SPI is subject of an application note and not mentioned here.

| VCP_REG_OV_BF_EN | Reaction  |
|------------------|---|
| 0                | ERROR reports error.  |
| 1                | ERROR reports error.<br>VCP_REG overvoltage bridge feedback is enabled:<br>1: When error flag <i>VCP_REG_OV</i> = 1 → bridge driver is set in tri-state.<br>0: When error flag <i>VCP_REG_OV</i> = 1 → no effect on bridge driver. This setting can be used to mask VCP_REG_OV event. |

### 4.2.3 Pre-driver Output State Summary

The table below shows all conditions due to which the pre-driver may be disabled.

| Pre-driver disabled (Z-state)   | Pre-driver released again                              |
|---|--|
| As soon as an error condition appears for which the hardware protection is activated.<br>VM_OV<br>VDS<br>VCP_REG_OV | As soon as the end of frame EOF has been acknowledged. |
| As soon as VCC is low.  | As soon as VCC is high.                                |
| As soon as ENABLE is low.   | As soon as ENABLE is high.                             |

## 5 EEPROM Default Configuration

A good pre-driver configuration is already done by JTMIC. The EEPROM features single error correction and double error detection.

### EEPROM PROGRAMMING

The EEPROM data can be programmed by the microcontroller via an SPI interface. In most cases it is not necessary to change EEPROM settings. Therefore, information about programming the EEPROM via SPI is subject of an application note and not mentioned here.

### MEMORY MAP

| SPI Address [2:0] | ED7                 | ED6       | ED5         | ED4            | ED3           | ED2   | ED1    | ED0  |
|-------------------|---------------------|-----------|-------------|----------------|---------------|-------|--------|------|
| 0                 | Res.                | Res.      | Res.        | Res.           | Res.          | Res.  | Res.   | Res. |
| 1                 | Res.                | Res.      | Res.        | Res.           | Res.          | Res.  | Res.   | Res. |
| 2                 | DEAD_TIME[2:0]      |           |             | VDSMON[2:0]    |               |       | CPMODE | Res. |
| 3                 | VDS_BLANK_TIME[1:0] |           | PWM_SPEED   | Res.           | CUR_GAIN[2:0] |       |        | Res. |
| 4                 | VREG_OV_B           | VDS_BF_EN | VDS_COMP_EN | VGS_UV_COMP_EN | 0             | EN_CP | Res.   | Res. |
| 5                 | SPI_EN              | 1         | Res.        | Res.           | Res.          | Res.  | Res.   | Res. |

### EEPROM BITS

| Bit name                    | Description  | Default |
|-----------------------------|--|---------|
| <b>Driver Configuration</b> |  |         |
| DEAD_TIME[2:0]              | Defines the DEAD TIME between the HS FET and LS FET of the same phase.<br>Default value: 1.0 $\mu$ s.  | 011     |
| VDSMON[2:0]                 | Defines the detection threshold level of the Vds monitoring. Default value: 2V.  | 111     |
| VDS_BLANK_TIME [1:0]        | Defines the duration of the Vds monitor blanking time after the on-transition of the FET. Default value: 3.0 $\mu$ s   | 10      |
| CUR_GAIN[2:0]               | Defines the gain of the current sense amplifier.<br>Default value: *17.2   | 011     |
| CPMODE                      | 0: VBOOST voltage is regulated relative to ground<br>1: VBOOST voltage is regulated relative to VSUP.  | 0       |
| <b>IC Configuration</b>     |  |         |
| SPI_EN                      | When set, the SPI block is enabled.<br>When reset, no SPI possible.<br>In SPI mode this value can only be programmed from 1 to 0, not from 0 to 1.               | 1       |
| VCP_REG_OV_BF_EN            | VCP_REG Overvoltage bridge feedback enable<br>1: When VCP_REG_OV = 1 → Bridge driver is SET in tri-state<br>0: When VCP_REG_OV = 1 → No effect on Bridge driver. | 1       |
| VDS_BF_EN                   | VDS bridge feedback enable<br>1: When VDS_ERR = 1 → Bridge driver is SET in tri-state.<br>0: When VDS_ERR = 1 → No effect on Bridge driver.                      | 1       |
| VDS_COMP_EN                 | 1: VDS comparator enabled<br>0: VDS comparator disabled  | 1       |
| VGS_UV_COMP_EN              | 1: gate-source undervoltage comparator enabled<br>0: gate-source undervoltage comparator disabled  | 0       |
| PWM_SPEED                   | 1: PWM = FERROR_F<br>0: PWM = FERROR_S (ERROR PWM frequency slow 12.5KHz.)   | 1       |
| EN_CP                       | 1: boost charge pump enabled<br>0: boost charge pump disabled  | 0       |
| OUT_RESERVE_RG              | Undefined  | 0       |

## 5.1 Basic Information for SPI Communication

To communicate with the TMC6130 via SPI the motor has to be in standstill because of pin sharing. When the chip is in SPI mode the EEPROM is programmable and readable via the SPI port.

The TMC6130 switches from *normal mode* to *SPI mode* if the following conditions are met:

- EN = 0
- ERROR:
  - ⊕ Any pending errors have been acknowledged
  - ⊕ All BHx = high
  - ⊕ All BLx = low
  - ⊕ A Low Level pulse is applied on ERROR between 256  $\mu$ s (2048 Tclk) and 512  $\mu$ s (4096 Tclk) )

The chip returns from SPI mode to normal mode when

- EN = 1.

This means that any ongoing EEPROM writes will be completed and the EEPROM state machine will copy all EEPROM contents into registers. Then the chip will return to normal mode. During this time the ERROR pin will be kept low.

When the TMC6130 comes out of power ON reset, after leaving SPI mode and returning to normal mode, the pre-driver will be blocked until the data have been copied to the registers. This assures that all chip parameters are set correctly.

It only makes sense for the CPU to call for SPI if all errors are clear and acknowledged.

## 6 Sense Amplifier

The sense amplifier offers very low input offset, and very fast settling times. The input range can be adjusted by applying a suitable voltage on the VREF pin, typically as a resistor divider on VCC. For the definition of VREF, the input offset, the current range, and the linear output range of the CURRENT pin should all be taken into account.

Input signal:  $V_{IN} = V_{ISP} - V_{ISN}$

Max. input offset:  $V_{OFFSET\_MAX} = V_{IS\_IO\_MAX} + T_{RANGE} * V_{IS\_IO\_TDRIFT}$

$T_{RANGE}$  = over the full temperature range

$V_{ISENSE} = (V_{IN} +/- V_{OFFSET}) * I_{SGAIN} + V_{REF}$  has to be in the range  $[V_{ISENSE\_MIN}, V_{ISENSE\_MAX}]$

$I_{MIN} = [(V_{ISENSE\_MIN} - V_{REF}) / I_{SGAIN} + V_{OFFSET}] / R_{SHUNT}$

$I_{MAX} = [(V_{ISENSE\_MAX} - V_{REF}) / I_{SGAIN} - V_{OFFSET}] / R_{SHUNT}$

| Symbol               | Parameter                          |
|----------------------|------------------------------------|
| $V_{IS\_IO}$         | Input offset voltage               |
| $V_{IS\_IO\_TDRIFT}$ | Input offset voltage thermal drift |
| $I_{SGAIN}$          | Closed loop gain                   |
| $V_{ISENSE\_MIN}$    | ISENSE output voltage range low    |
| $V_{ISENSE\_MAX}$    | ISENSE output voltage range high   |
| $V_{REF}$            | Reference voltage input            |

The table below shows the current input range for two resistive divider settings on VREF.

- $V_{REF} = VCC/2$  for a symmetrical input range
- $V_{REF} = VCC/18$  for a maximum current level, whilst ensuring it is possible to measure the input offset before starting the motor ( $I_{SENSE\_MIN} > 0A$ ).

For ease of calculation a max temperature offset drift of 1mV was added to the 5mV offset. From this follows that the maximum input offset is 6mV.

| VCC        | 3.3      | 3.3       | 3(**)    | 3(**)     | 5        | 5         | 4.5(**)  | 4.5(**)   |
|------------|----------|-----------|----------|-----------|----------|-----------|----------|-----------|
| Visensemin | 0.02     | 0.02      | 0.02     | 0.02      | 0.02     | 0.02      | 0.02     | 0.02      |
| Visensemax | 3.28     | 3.28      | 2.98     | 2.98      | 4.98     | 4.98      | 4.48     | 4.48      |
| <b>div</b> | <b>2</b> | <b>18</b> | <b>2</b> | <b>18</b> | <b>2</b> | <b>18</b> | <b>2</b> | <b>18</b> |
| VREF       | 1.65     | 0.18      | 1.50     | 0.17      | 2.50     | 0.28      | 2.25     | 0.25      |
| Voffset    | 0.006    |           |          |           |          |           |          |           |

## 6.1 Sense Amplifier Current Ranges: Examples for 1M $\Omega$ Shunt

### $I_{SENSE\_MIN}$

| Gain        | DIV2 | DIV18  | DIV2 | DIV18  | DIV2 | DIV18 | DIV2 | DIV18 |
|-------------|------|--------|------|--------|------|-------|------|-------|
| <b>8</b>    | -198 | -14.4  | -179 | -12    | -304 | -26.2 | -273 | -23   |
| <b>10.3</b> | -152 | -9.9   | -138 | -8     | -235 | -19.0 | -211 | -16   |
| <b>13.3</b> | -117 | -6.3   | -105 | -5     | -180 | -13.4 | -162 | -11   |
| <b>17.2</b> | -89  | -3.5   | -80  | -3     | -138 | -9.0  | -124 | -7    |
| <b>22.2</b> | -67  | -1.4   | -61  | -0.6   | -106 | -5.6  | -94  | -4    |
| <b>28.7</b> | -51  | 0.3(*) | -46  | 0.9(*) | -80  | -3.0  | -72  | -2    |
| <b>37.0</b> | -38  | 1.6(*) | -34  | 2.0(*) | -61  | -1.0  | -54  | 0     |
| <b>47.8</b> | -28  | 2.6(*) | -25  | 3(*)   | -46  | 0.6   | -41  | 1     |

- (\*) Applying a GAIN of 28.7 or higher with DIV 18 for 3.3V does not allow the measure the input offset
- (\*\*) examples taking a 10% supply variation into account.

### $I_{SENSE\_MAX}$

| Gain        | DIV2 | DIV18 | DIV2 | DIV18 | DIV2 | DIV18 | DIV2 | DIV18 |
|-------------|------|-------|------|-------|------|-------|------|-------|
| <b>8</b>    | 198  | 381   | 179  | 346   | 304  | 582   | 273  | 523   |
| <b>10.3</b> | 152  | 295   | 138  | 267   | 235  | 451   | 211  | 405   |
| <b>13.3</b> | 117  | 227   | 105  | 206   | 180  | 348   | 162  | 312   |
| <b>17.2</b> | 89   | 174   | 80   | 158   | 138  | 267   | 124  | 240   |
| <b>22.2</b> | 67   | 133   | 61   | 121   | 106  | 206   | 94   | 185   |
| <b>28.7</b> | 51   | 102   | 46   | 92    | 80   | 158   | 72   | 141   |
| <b>37.0</b> | 38   | 78    | 34   | 70    | 61   | 121   | 54   | 108   |
| <b>47.8</b> | 28   | 59    | 25   | 53    | 46   | 92    | 41   | 82    |

## 7 FET Driver Implementation

### 7.1 Normal Operation

The top side FET drivers are bootstrapped drivers. Each of the six external FET transistors which have to be connected can be controlled directly via six digital inputs.

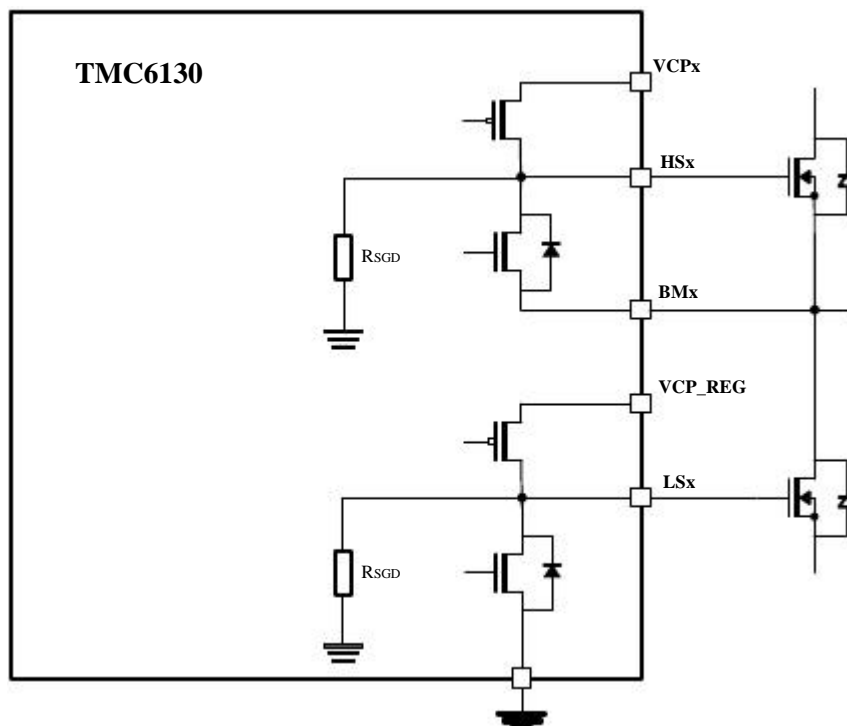
The six external FET transistors (or three half bridges) can also be controlled using only three digital input signals. Therefore, proceed as follows:

- Connect the BHx to VCC.
- Control the 3 phases via the BLx inputs. In this mode of operation, the TMC6130 will automatically generate the programmed dead times.

The drain source voltage VDS as well as the gate voltage VGS are monitored to ensure fail safe operation. The FET gate outputs are all pulled low by pulling ENABLE low.

### 7.2 FET Driver during Sleep Mode

In sleep mode, a gate discharge resistance ( $R_{SGD} \sim 1K\Omega$ ) is activated. This ensures that the FET gates remain fully in OFF state. It is the responsibility of the microcontroller to ensure all gate voltages are low, for instance by setting the ENABLE input low, prior to switching to sleep mode.



**Figure 7.1** Fet driver during sleep mode: BMx is kept low with HSx through the internal body diode of the TMC6130.

## 8 Absolute Maximum Ratings

The maximum ratings may not be exceeded under any circumstances. Operating the circuit at or near more than one maximum rating at a time for extended periods shall be avoided by application design. All voltages are referenced to ground (GND). Positive currents flow into the IC. The absolute maximum ratings given in the table below are limiting values that do not lead to a permanent damage of the device but exceeding any of these limits may do so. Long term exposure to limiting values may affect the reliability of the device. Reliable operation of the IC is only specified within the limits shown in the table.

| Parameter                                | Symbol               | Condition                                  | Min                     | Max     | Unit |
|--|----------------------|--|-------------------------|---------|------|
| Supply voltage                           | V <sub>M</sub>       | t < 200ms * <sup>1)</sup>                  | -0.5                    | 45      | V    |
|  | V <sub>MON</sub>     | permanent (functional)                     | -0.5                    | 28      | V    |
| Voltage on analogue LV                   | V <sub>AN_LV</sub>   |  | -0.5                    | VCC+0.5 | V    |
| Digital output voltage                   | V <sub>OUT_DIG</sub> |  | -0.5                    | VCC+0.5 | V    |
| Digital input voltage                    | V <sub>IN_DIG</sub>  |  | -0.5                    | VCC+0.5 | V    |
| Digital input current                    | I <sub>IN_DIG</sub>  |  | -10                     | 10      | mA   |
| Input voltage on BMx pins                | V <sub>IN_BMx</sub>  |  | -2                      | 45      | V    |
| Maximum latch-up free current at any pin | I <sub>LATCH</sub>   | according JEDEC JESD78, AEC-Q100-004       | -100                    | 100     | mA   |
| ESD capability of any other pin          | ESD                  | human body model * <sup>2)</sup>           | -2                      | +2      | kV   |
| Storage temperature                      | t <sub>STG</sub>     |  | -55                     | 150     | °C   |
| Junction temperature                     | t <sub>J</sub>       | * <sup>3)</sup>                            | -40                     | 150     | °C   |
| Thermal resistance package               | R <sub>THJA</sub>    | in free air on multilayer pcb (JEDEC 1s2p) | (37)<br>to be confirmed | K/W     |      |
|  | R <sub>THJC</sub>    | referring to center of exposed pad         | (10)<br>to be confirmed | K/W     |      |

### NOTES

\*<sub>1)</sub> Only during load dump pulse.

\*<sub>2)</sub> Equivalent to discharging a 100pF capacitor through a 1.5kΩ resistor conform to MIL STD 883 method 3015.7

\*<sub>3)</sub> For applications with t<sub>J</sub> > 125°C: the extended temperature range is only allowed for a limited period of time. The application mission profile has to be agreed by JTMIC. Some analogue parameters may drift out of limits, but chip function is guaranteed.

## 9 General Electrical Specifications

### 9.1 Operational Range (*unless otherwise specified*)

| Parameter                                  | Symbol   | Min | Max | Unit |
|--|----------|-----|-----|------|
| Application temperature                    | $t_A$    | -40 | 125 | °C   |
| Supply voltage TMC6130                     | $V_M$    | 7   | 18  | V    |
| V <sub>CC</sub> logic supply input voltage | $V_{CC}$ | 3   | 5.5 | V    |

| BATTERY SUPPLY                              |                  |  |     |     |     |       |
|---|------------------|--|-----|-----|-----|-------|
| Parameter                                   | Symbol           | Test Conditions  | Min | Typ | Max | Units |
| Supply voltage                              | $V_M$            |  | 7   |     | 18  | V     |
| Supply voltage extended range low           | $V_{M\_ERL}$     | Functional with relaxed specification.   | 4.5 |     | 7   | V     |
| Supply voltage extended range high          | $V_{M\_ERH}$     | Functional with relaxed specification.   | 18  |     | 28  | V     |
| Quiescent current drawn from V <sub>M</sub> | $I_{MSLEEP}$     | V <sub>CC</sub> = low  |     |     | 30  | μA    |
| Operating current drawn from V <sub>M</sub> | $I_{M\_INT}$     | Pre-driver operation without charge pump operation (EN_CP=0).                  |     |     | 1   | mA    |
| Battery overvoltage threshold high          | $V_{M\_OVH}$     | Warning on ERROR.  |     |     | 35  | V     |
| Battery overvoltage threshold low           | $V_{M\_OVL}$     | ERROR released.  | 31  |     |     | V     |
| Battery overvoltage threshold hyst          | $V_{M\_OV\_HY}$  |  | 0.4 | 1   |     | V     |
| Battery overvoltage debounce time           | $V_{M\_OV\_DEB}$ |  |     |     | 2   | μS    |
| Battery undervoltage threshold high         | $V_{M\_UVH}$     | Warning on ERROR.  |     |     | 6   | V     |
| Battery undervoltage threshold low          | $V_{M\_UVL}$     | ERROR released.  | 5   |     |     | V     |
| Battery undervoltage threshold hyst         | $V_{M\_UVHY}$    |  | 0.2 | 0.5 |     | V     |
| Battery undervoltage debounce time          | $V_{M\_UV\_DEB}$ |  |     |     | 10  | μS    |
| Power on reset level                        | $V_{POR}$        | Reset released on rising edge of V <sub>M</sub> while V <sub>CC</sub> is high. | 3   |     | 4.5 | V     |

| POWER AND TEMPERATURE           |        |                   |     |     |     |       |
|---------------------------------|--------|-------------------|-----|-----|-----|-------|
| Parameter                       | Symbol | Test Conditions   | Min | Typ | Max | Units |
| Overtemperature protection high | OTH    | Warning on ERROR. | 153 | 166 | 183 | °C    |
| Overtemperature protection low  | OTL    | ERROR released.   | 123 | 137 | 153 | °C    |

| VCC IO SUPPLY INPUT                       |             |  |      |      |     |       |
|---|-------------|--|------|------|-----|-------|
| Parameter                                 | Symbol      | Test Conditions  | Min  | Typ  | Max | Units |
| VCC operating current                     | Icc         | Maximum input current includes ERROR current sourcing. |      |      | 20  | mA    |
| VCC pull down resistance                  | VCC_RPD     |  | 230  | 300  | 370 | KΩ    |
| VCC input voltage                         | Vcc         | Vcc = 3.3V or 5V, logic supply.                        | 3    |      | 5.5 | V     |
| VCC input undervoltage high <sup>1)</sup> | VCC_UV_H    | VCC increasing, NFET control is activated.             | 2.7  |      | 2.8 | V     |
| VCC input undervoltage low                | VCC_UV_L    | Vcc decreasing, disable NFET control.                  | 2.6  |      | 2.7 | V     |
| VCC input undervoltage hyst               | VCC_UV_HY   |  | 0.07 | 0.1  |     | V     |
| VCC sleep voltage high                    | VCC_SLEEP_H | Vcc increasing, out of sleep.                          | 2.45 |      | 2.6 | V     |
| VCC sleep voltage low                     | VCC_SLEEP_L | Vcc decreasing, go to sleep.                           | 1.9  |      | 2   | V     |
| VCC sleep voltage hyst                    | VCC_SLEEP_H |  | 0.45 | 0.58 |     | V     |

<sup>1)</sup> The info VCC\_UV\_X is used to disable the control of the external FETs.

| ON-CHIP OSCILLATOR          |          |   |               |     |               |       |
|-----------------------------|----------|---|---------------|-----|---------------|-------|
| Parameter                   | Symbol   | Test Conditions                             | Min           | Typ | Max           | Units |
| Charge pump frequency       | FCP      |   | 170           |     | 230           | KHz   |
| ERROR PWM frequency fast    | FERROR_F |   | 85            |     | 115           | KHz   |
| ERROR PWM frequency slow    | FERROR_S |   | 10.6          |     | 14.4          | KHz   |
| SPI start up pulse duration | tsPI_SU  | EN = Low<br>BH1/2/3 = low<br>BL1/2/3 = high | 2048/F<br>OSC |     | 4096/F<br>OSC | Sec   |

The charge pump of the TMC6130 can be used with three modes of operation.

| <b>CHARGE PUMP / CPMODE=X</b><br>(Silicon diodes BAS16, Ccp=1μF, Cboost=1μF + Creg=4.7μF: to be confirmed) |                     |  |     |     |     |       |
|--|---------------------|--|-----|-----|-----|-------|
| Parameter  | Symbol              | Test Conditions  | Min | Typ | Max | Units |
| Resistive load from VCP to GND   | RCP_LEAK            | R <sub>TYP</sub> = room temperature<br>R <sub>MIN</sub> = 150C<br>(excl. R <sub>VCP_REG_LEAK</sub> ) | 6   | 8   |     | MΩ    |
| Output slew rate   |                     |  |     | 100 |     | V/us  |
| Charge pump frequency  | F <sub>CP</sub>     |  | 170 | 200 | 230 | kHz   |
| VCP undervoltage (VCP high)  | V <sub>CP_UVH</sub> | ERROR released.  |     |     | 7.2 | V     |
| VCP undervoltage (VCP low)   | V <sub>CP_UVL</sub> | Warning on ERROR.  | 5.7 |     | 6.7 | V     |

| <b>CHARGE PUMP / CPMODE=0</b><br>(Silicon diodes BAS16, Ccp=1μF, Cboost=1μF + Creg=4.7μF: to be confirmed) |                           |  |     |     |     |       |
|--|---------------------------|--|-----|-----|-----|-------|
| Parameter  | Symbol                    | Test Conditions  | Min | Typ | Max | Units |
| CP Load current on VCP_REG   | I <sub>CP_REG_MODE0</sub> | V <sub>CP_REG</sub> > 11V<br>EN_CP = 1                 |     |     | 40  | mA    |
| Output voltage VCP_REG   | V <sub>REG</sub>          | V <sub>M</sub> > 8V<br>I <sub>reg</sub> < 40mA         | 11  | 12  | 13  | V     |
| Output voltage VCP_REG   | V <sub>CP_REG</sub>       | V <sub>M</sub> = [7,8]V<br>I <sub>VCP_REG</sub> < 40mA | 10  |     | 13  | V     |
| VCP Undervoltage, (VCP high)   | V <sub>CP_UVH</sub>       | ERROR released.  |     |     | 7.2 | V     |
| VCP Undervoltage, (VCP low)  | V <sub>CP_UVL</sub>       | Warning on ERROR.                                      | 5.7 |     | 6.7 | V     |

| <b>CHARGE PUMP / CPMODE=1</b><br>(Silicon diodes BAS16, Ccp=1μF, Cboost=1μF + Creg=4.7μF: to be confirmed) |                           |   |     |     |     |       |
|--|---------------------------|---|-----|-----|-----|-------|
| Parameter  | Symbol                    | Test Conditions                                   | Min | Typ | Max | Units |
| CP load current on VCP_REG   | I <sub>CP_REG_MODE1</sub> | V <sub>REG</sub> > 11V<br>EN_CP = 1               |     |     | 20  | mA    |
| Reverse polarity NFET gate voltage (V <sub>CP</sub> – V <sub>M</sub> )                                     | V <sub>GS_RPFET</sub>     | V <sub>M</sub> > 7<br>I <sub>VCP_REG</sub> < 20mA | 5   | 12  | 13  | V     |
| Output voltage VCP_REG   | V <sub>CP_REG</sub>       | I <sub>REG</sub> < 20mA                           | 11  | 12  | 13  | V     |
| VCP undervoltage, (V <sub>CP</sub> – V <sub>M</sub> ) high   | V <sub>CP_UVH</sub>       | ERROR released.                                   |     |     | 7.2 | V     |
| VCP undervoltage, (V <sub>CP</sub> – V <sub>M</sub> ) low  | V <sub>CP_UVL</sub>       | Warning on ERROR.                                 | 5.7 |     | 6.7 | V     |

| VREG Warnings / CPMODE=X                    |               |  |      |     |      |       |
|---|---------------|--|------|-----|------|-------|
| Parameter                                   | Symbol        | Test Conditions                                    | Min  | Typ | Max  | Units |
| Internal resistive load from VCP_REG to GND | RVCP_REG_LEAK | R <sub>TYP</sub> = Room<br>R <sub>MIN</sub> = 150C | 0.3  | 0.4 |      | MΩ    |
| VCP_REG overvoltage high                    | VCP_REG_OVH   | Warning on ERROR.                                  | 14.2 |     | 16.5 | V     |
| VCP_REG overvoltage low                     | VCP_REG_OVL   | ERROR released.                                    | 13.5 |     |      | V     |
| VCP_REG overvoltage hyst                    | VCP_REG_OVHY  |  | 0.7  | 1   |      | V     |
| VCP_REG undervoltage high                   | VCP_REG_UVH   | ERROR released.                                    |      |     | 8.1  | V     |
| VCP_REG undervoltage low                    | VCP_REG_UVL   | Warning on ERROR.                                  | 6.9  |     | 7.8  | V     |

| VBATF                             |            |                                  |     |     |     |       |
|-----------------------------------|------------|----------------------------------|-----|-----|-----|-------|
| Parameter                         | Symbol     | Test Conditions                  | Min | Typ | Max | Units |
| Internal leakage from VMON to GND | RVMON_LEAK | Pre-driver is not in sleep mode. |     |     | 20  | μA    |

| FET GATE DRIVERS  |                       |   |        |   |        |       |
|---|-----------------------|---|--------|---|--------|-------|
| Parameter   | Symbol                | Test Conditions   | Min    | Typ   | Max    | Units |
| Driver ON resistance <sup>2)</sup>  | RDR_ON                |   |        | 4   | 8      | Ω     |
| Rise time   | t <sub>R</sub>        | C <sub>load</sub> = 1nF, 20% to 80%                                       | 6      | 7   | 15     | ns    |
| Fall time   | t <sub>F</sub>        | C <sub>load</sub> = 1nF, 80% to 20%                                       | 4      | 7   | 15     | ns    |
| Pull-up on resistance   | R <sub>ON_UP</sub>    | -10mA t <sub>r</sub> = -40<br>-10mA, t <sub>r</sub> = 150                 | 2.4    |   | 6.5    | Ω     |
| Pull down on resistance   | R <sub>ON_DN</sub>    | 10mA t <sub>r</sub> = -40<br>10mA, t <sub>r</sub> = 150                   | 1.5    |   | 5.7    | Ω     |
| Turn on gate drive peak current   | I <sub>G_ON</sub>     | V <sub>GS</sub> = 0V  |        | -1  | -1.4   | A     |
| Turn off gate drive peak current  | I <sub>G_OFF</sub>    | V <sub>GS</sub> = 12V   |        | 1   | 1.6    | A     |
| Propagation delay   | t <sub>PD_DRV</sub>   | From logic input threshold to 2V V <sub>GS</sub> drive output at no load. | 20     |   | 100    | ns    |
| Propagation delay matching  | t <sub>PD_DRVM</sub>  | Transitions at the different phases at no load condition.                 | -20    |   | 20     | ns    |
| Programmable dead time : asynchronous internal delay between top and bottom FET | t <sub>DEAD</sub>     | DEAD_TIME[2:0] = 000<br>001<br>010<br>011<br>100<br>101<br>110<br>111     | 0.0001 | 0<br>0.5<br>0.75<br>1.0<br>1.5<br>2.0<br>3.0<br>6.0 | 0.0002 | μs    |
| Dead time tolerance   | t <sub>DEAD_TOL</sub> |   | -15    |   | 15     | %     |

| FET GATE DRIVERS   |                      |  |      |                       |      |                    |
|--|----------------------|--|------|-----------------------|------|--------------------|
| Parameter  | Symbol               | Test Conditions  | Min  | Typ                   | Max  | Units              |
| Programmable V <sub>DS</sub> monitor voltage   | V <sub>DS_MON</sub>  | VDSMON[2:0] = 000:<br>disabled   | 0.4  | 0.5<br>0.75           | 0.6  | V                  |
|  |                      | 001  | 0.6  | 1.00                  | 0.9  |                    |
|  |                      | 010  | 0.85 | 1.25                  | 1.15 |                    |
|  |                      | 011  | 1.05 | 1.50                  | 1.45 |                    |
|  |                      | 100  | 1.25 | 1.75                  | 1.75 |                    |
|  |                      | 101  | 1.5  | 2.00                  | 2.00 |                    |
|  |                      | 110  | 1.70 |                       | 2.3  |                    |
|  |                      | 111  |      |                       |      |                    |
|  |                      |  |      |                       |      |                    |
| Programmable V <sub>DS</sub> monitor blanking time: internal delay between GATE signal high and enabling the corresponding V <sub>DS</sub> monitor | tv <sub>DS_BL</sub>  | VDS_BLANK_TIME[1:0] = 00<br>01<br>10<br>11   |      | 0.75<br>1.5<br>3<br>6 |      | μs                 |
| V <sub>DS</sub> blanking time tolerance  | tv <sub>DS_TOL</sub> |  | -15  |                       | 15   | %                  |
| Sleep gate discharge resistor  | R <sub>SGD</sub>     | Internal resistance between FET gate-source pins to switch-off FET.<br>V <sub>CC</sub> = 0V (sleep mode)<br>V <sub>GS</sub> = 0.5V<br><i>See chapter FET driver during sleep mode.</i> |      |                       | 1    | KΩ                 |
| V <sub>GS</sub> under voltage monitor  | V <sub>GS_UV</sub>   | Warning on ERROR.  | TBD  |                       | 75   | % V <sub>REG</sub> |
| PWM frequency  | F <sub>PWM</sub>     |  | 5    | 20                    | 100  | KHz                |
| Leakage from VCP <sub>x</sub> to BM <sub>x</sub>   | R <sub>CP_LEAK</sub> | Typ = Room<br>Min = 150C   | 0.75 | 1                     |      | MΩ                 |

<sup>2)</sup> The driver on resistance is <5Ω at 25°C. Maximum values correspond with 150°C.

| Logic IO (FET inputs, EN input) |                        |   |     |     |     |                   |
|---------------------------------|------------------------|---|-----|-----|-----|-------------------|
| Parameter                       | Symbol                 | Test Conditions   | Min | Typ | Max | Units             |
| Digital input high voltage      | V <sub>IN_DIG_H</sub>  | Minimum voltage for input to be treated as logical high |     |     | 70  | % V <sub>CC</sub> |
| Digital input low voltage       | V <sub>IN_DIG_L</sub>  | Maximum voltage for input to be treated as logical low  | 30  |     |     | % V <sub>CC</sub> |
| Input pull-up resistance        | R <sub>IN_DIG_PU</sub> | BL1, BL2, BL3   | 90  |     | 410 | KΩ                |
| Input pull-down resistance      | R <sub>IN_DIG_PD</sub> | BH1, BH2, BH3   | 90  |     | 410 | KΩ                |
| Input pull-down resistance      | R <sub>EN_PD</sub>     | ENABLE  | 90  |     | 410 | KΩ                |

| SPI TIMING             |                      |                 |     |     |     |       |
|------------------------|----------------------|-----------------|-----|-----|-----|-------|
| Parameter              | Symbol               | Test Conditions | Min | Typ | Max | Units |
| SPI initial setup time | ts <sub>PI_ISU</sub> |                 | 2   |     |     | μsec  |
| SPI clock frequency    | F <sub>SPI</sub>     |                 |     |     | 500 | KHz   |

| SPI TIMING           |         |   |     |     |     |       |
|----------------------|---------|---|-----|-----|-----|-------|
| Parameter            | Symbol  | Test Conditions                             | Min | Typ | Max | Units |
| Rise/fall times      | tSPI_RF | All rise/fall times on CLK, CSB, MISO, MOSI |     |     | 200 | nsec  |
| CSB setup time       | tCSB_SU |   | 1   |     |     | μsec  |
| CSB high time        | tCSB_H  |   | 2   |     |     | μsec  |
| Clock high time      | tCLK_H  |   | 1   |     |     | μsec  |
| Clock low time       | tCLK_L  |   | 1   |     |     | μsec  |
| Data in setup time   | tDI_SU  |   | 1   |     |     | μsec  |
| Data in hold time    | tDI_H   |   | 500 |     |     | μsec  |
| Data out ready delay | tDO_R   | Cload at BL1<50pF                           |     | 500 |     | μsec  |
| EEPROM read delay    | tEE_RD  | EE_RD = 1                                   | 6   |     |     | μsec  |
| EEPROM write delay   | tEE_WR  | EE_RD = 1                                   | 12  |     |     | msec  |

| ERROR OUTPUT      |                       |                                      |       |     |     |       |
|-------------------|-----------------------|--------------------------------------|-------|-----|-----|-------|
| Parameter         | Symbol                | Test Conditions                      | Min   | Typ | Max | Units |
| Pull-up current   | I <sub>ERROR_PU</sub> | V <sub>ERROR</sub> = 0V              | -2.23 |     | -5  | mA    |
| Pull-down current | I <sub>ERROR_PD</sub> | V <sub>ERROR</sub> = V <sub>CC</sub> | 5     |     | 2.6 | mA    |

| ENABLE INPUT                     |                      |   |     |     |     |       |
|----------------------------------|----------------------|---|-----|-----|-----|-------|
| Parameter                        | Symbol               | Test Conditions   | Min | Typ | Max | Units |
| Bridge disable propagation delay | EN <sub>PR_DEL</sub> | From bridge enable EN< 0.2*V <sub>CC</sub> to V <sub>GS</sub> <0.5V with Cload=1nF. |     |     | 1   | μs    |

| CURRENT SENSE AMPLIFIER                                      |                           |  |                         |   |                 |                  |
|--|---------------------------|--|-------------------------|---|-----------------|------------------|
| Parameter  | Symbol                    | Test Conditions  | Min                     | Typ   | Max             | Units            |
| Input offset voltage   | V <sub>IS_IO</sub>        | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V. | -5                      |   | 5               | mV               |
| Input offset voltage thermal drift                           | V <sub>IS_IO_TDRIFT</sub> | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V. | -10                     |   | 10              | μV/°C            |
| Input common mode rejection DC                               | I <sub>SCMR_DC</sub>      | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V. | 60                      |   |                 | dB               |
| Input common mode rejection 1MHz                             | I <sub>SCMRR_AC</sub>     | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V. | 40                      |   |                 | dB               |
| Input power supply rejection DC for V <sub>CC</sub> supply   | I <sub>SPSRR_DC</sub>     | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V  | 60                      |   |                 | dB               |
| Input power supply rejection 1MHz for V <sub>CC</sub> supply | I <sub>SPSRR_AC</sub>     | Input diff. voltage within +/-100mV;<br>common mode within -0.5... 1.0V. | 40                      |   |                 | dB               |
| Closed loop gain   | I <sub>SGAIN</sub>        | Gain is programmable in EEPROM.  | -3%                     | 8.0<br>10.3<br>13.3<br>17.2<br>22.2<br>28.7<br>37.0<br>47.8 | +3%             | -                |
| Output settling time   | I <sub>SSET</sub>         | Amplified output to 99% of final value after input change.               |                         |   | 1.0             | μs               |
| Output voltage range high                                    | V <sub>CURRENT_MAX</sub>  | Current sense output max level.  | V <sub>CC</sub> - 0.020 |   | V <sub>CC</sub> | V                |
| Output voltage range low                                     | V <sub>CURRENT_MIN</sub>  | Current sense output min level.  | GND                     |   | GND +0.020      | V                |
| Output short circuit current to ground                       | I <sub>CURRENT_SC</sub>   | Output current saturation level.   |                         | 1.4   |                 | mA               |
| GBW  | I <sub>SGBW</sub>         |  | 10                      |   |                 | MHz              |
| Output slew rate   | I <sub>SSR</sub>          |  |                         | 40  |                 | V/μs             |
| CM spike recovery  | I <sub>SCM_REC</sub>      | CM spike = ±1.5V<br>duration = 250nsec                                   |                         |   | 730             | nS               |
| VREF voltage input   | V <sub>REF</sub>          |  | 0                       |   | 50              | %V <sub>CC</sub> |

## 10 Package Mechanical Data

### 10.1 QFN32 Dimensional Drawings

Attention: Drawings not to scale.

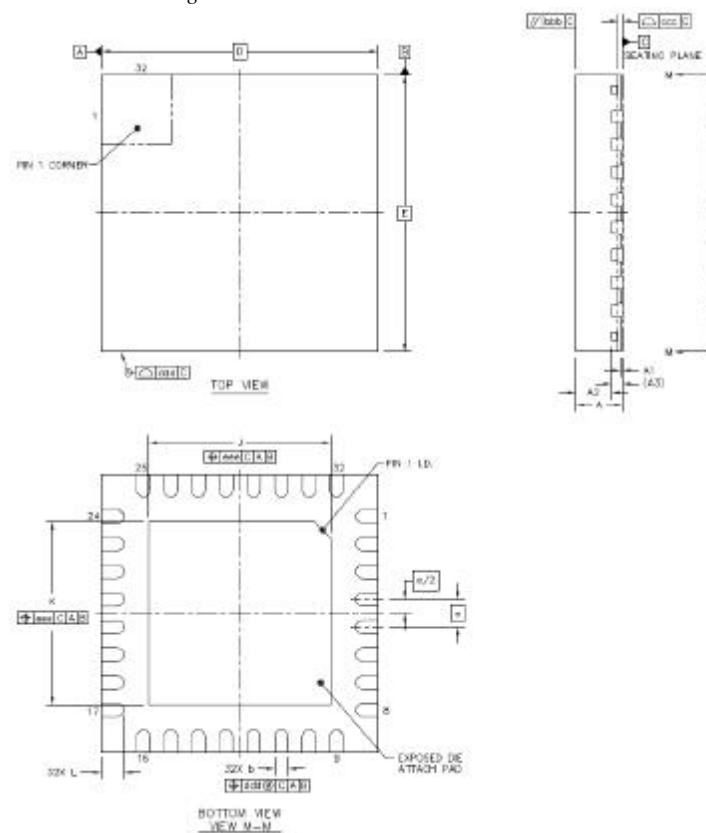


Figure 10.1 Dimensional drawings

| Parameter              | Ref | Min  | Nom  | Max  |
|------------------------|-----|------|------|------|
| Total thickness        | A   | 0.80 | 0.85 | 1.00 |
| Standoff               | A1  | 0.00 | 0.05 | 0.05 |
| Lead frame thickness   | A3  |      | 0.2  |      |
| Lead width             | b   | 0.18 |      | 0.3  |
| Body size X            | D   |      | 5.0  |      |
| Body size Y            | E   |      | 5.0  |      |
| Lead pitch             | e   |      | 0.5  |      |
| Exposed die pad size X | J   | 3.5  |      | 3.7  |
| Exposed die pad size Y | K   | 3.5  |      | 3.7  |
| Lead length            | L   | 0.3  |      | 0.5  |

General tolerance of D and E is  $\pm 0.1\text{mm}$ .

Bottom pin 1 identification may vary depending on supplier.

### 10.2 Package Code

| Device  | Package      | Temperature range | Code/ Marking |
|---------|--------------|-------------------|---------------|
| TMC6130 | QFN32 (RoHS) | -40 ° to +125 °C  | TMC6130-LA    |

## 11 Disclaimer

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## 12 ESD Sensitive Device

The TMC6130 is an ESD-sensitive CMOS device and sensitive to electrostatic discharge. Take special care to use adequate grounding of personnel and machines in manual handling. After soldering the devices to the board, ESD requirements are more relaxed. Failure to do so can result in defects or decreased reliability.



*Note: In a modern SMD manufacturing process, ESD voltages well below 100V are standard. A major source for ESD is hot-plugging the motor during operation. As the power MOSFETs are discrete devices, the device in fact is very rugged concerning any ESD event on the motor outputs. All other connections are typically protected due to external circuitry on the PCB.*

## 13 Table of Figures

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## 14 Revision History

| Version | Date        | Author<br>SD – Sonja Dwersteg | Description                   |
|---------|-------------|-------------------------------|-------------------------------|
| 0.9     | 2014-MAR-10 | SD                            | Initial version; preliminary. |

## 15 References

[TMC6130-EVAL] TMC6130-EVAL Manual

Please refer to our web page <http://www.jtmic.com>.